

<b>Notice of References Cited</b>	Application/Control No. 10/629,983		Applicant(s)/Patent Under Reexamination LI, KE-YI	
	Examiner Anthony Weier		Art Unit 1761	Page 1 of 1

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*	B	US-4,407,840	10-1983	Lathrop et al.	426/629
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